FORM PTO-1449 U.S. Department of Commerce TY. DOCKET NO. SERIAL NO. (Rev. 4/92) Patent and Trademark Office 1021.43435X00 10/767,059 INFORMATION DISCLOSURE RADEM STATEMENT BY APPLICANT APPLICANT CHO et al (Use several sheets if necessary) FILING DATE GROUP Jan. 30, 2004

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	0000	MENT N	JMBER					OATE	NAME	CLASS	SUBCLASS	FILING DATE
	5	7	4	3	2	6	2	4/98	Lepper, Jr.			
	6	2	8	0	3	8	1	8/01	Malin			
	5	7	2	5	4	8	0	3/98	Oosta			
	6	3	5	3	2	2	6	3/02	Khalil			

FOREIGN PATENT DOCUMENTS

	DOCUMEN	T NUMBI	ER					OATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
												YES	NO
	11	3	1	8	8	7	2	11/99	Japan			x	
	11	1	5	5	8	4	0	6/99	Japan			X.	
	11	5	0	5	4	5	1	5/99	Japan			×	
	2000	0	7_	4	8	2	9	3/2000	Japan	/		x	
	06	3	1	7	5	6	6	11/94	Japan			×	
	2002	5	3	5	0	2	3	10/02	Japan			×	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

7	·

EXAMINER/Etsub Berhanu/ (06/15/2008) DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO					t of Co		:e		ATTY.	DOCKET NO.		SERIAL NO.					
		IEODI	моть	ON D	ISCLO	SELIDI	_		1021	.43435X00	10/767,05	0/767,059					
					APPL				APPLIC	APPLICANT CHO et al							
		(Use s	everal :	sheets	if nece	ssary)			FILING	FILING DATE Jan. 30, 2004			GROUP				
						- 1	J.S.	PATE	NT DO	T DOCUMENTS							
EXAMINER INITIAL	ER DOCUMENT NUMBER								DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE				
												1					
											1	1					
											1						
											1						
FOREIG	N P.	ATE	NT D	ocu	IMEN	ITS			•								
	DO	CUMENT	NUMBER						DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO	N			
	1						r						YES	NO			
	20	000	5	0	6	0	4	8	5/2000	Japan			x				
	20	003	5	1	0	5	5	6	3/2003	Japan		Х_	×				
	08	3	3	2	2	8	2	1	12/96	Japan			×				
	╄-													ļ			
	<u> </u>			_							_						
							l										
OTHER	DO	сим	ENT	S (In	cludi	ing A	utho	or, Tit	le, Date	, Pertinent Pag	es, Et	c.)					
			1														
	L_																
EXAMINER /Etsub Berhanu/ (06/15/2008)								DATE CONSIDERED									

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.